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(12) **United States Design Patent** (10) **Patent No.:** **US D779,464 S**
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(54) **RFID TAG INLAY**
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(**) Term: **15 Years**

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(52) **U.S. Cl.**
USPC **D14/230**

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D13/182; D8/396; 248/68.1
CPC H01L 33/48; H01L 33/486; H01L 23/02;
H05K 5/00; H01Q 13/10; H01Q
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See application file for complete search history.

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(57) **CLAIM**

The ornamental design for an RFID tag inlay, as shown and described.

DESCRIPTION

The sole FIGURE is a top plan view of an RFID tag inlay showing my new design.

The solid black areas constitute the entirety of the claimed design. All elements of the claimed design are flat and coplanar.

1 Claim, 1 Drawing Sheet



